



Trends in Particle Beam Diagnostics

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Symposium on
Quantum Systems and Research at Accelerators
Cockcroft Institute, UK - May 16th 2012



Introduction to Beam Instrumentation

- **Beam instrumentation provides “eyes” for machine operators**
 - The instruments that observe beam behaviour
 - An accelerator can never be better than the instruments measuring its performance!
- **What does work in beam instrumentation entail?**
 - Design, construction & operation of instruments to observe particle beams
 - R&D to innovate or improve existing techniques to fulfill new requirements
 - A combination of many disciplines
 - Applied & Accelerator Physics and a lot of Mechanical, Electronic & Software Engineering
 - **A fascinating field of work!**
- **What are the main beam parameters measured?**
 - Beam Position to control location of the beam in the accelerator
 - Beam Intensity to measure operational efficiency
 - Beam Loss to ensure safe operation
 - Transverse Beam profiles
 - Longitudinal Beam profiles

} to optimise operation



Trends in Accelerators

- **Bigger, Faster, Better!**

- High energy machines for particle physics
 - LHC, HL-LHC, HE-LHC (CERN)
 - CLIC/ILC (R&D)
- High current machines
 - Neutron sources – material science
 - SNS (US), ESS (Sweden), CSNS (China), IFMIF (Japan), ...
 - Neutrino Production
 - T2K (JPARC, Japan), NuMI/Nova (FNAL, US), CNGS (CERN), Project-X (FNAL, US), ...
- High Brightness machines
 - X-ray Free Electron Lasers – probing complex, ultra-small structures
 - LCLS (SLAC, US), European XFEL (DESY, DE), ...

- **Compact or Exotic!**

- Rare radioactive isotope machines
 - FAIR (GSI, DE), HIE-ISOLDE (CERN)
- Anti-matter machines
 - ELENA (CERN), FAIR (GSI, DE)
- Medical proton/ion therapy machines



Challenges for Beam Instrumentation

- **Unprecedented request for precision**
 - Positioning down to well below the micron level
- **Treatment of increasingly more data**
 - Bunch by bunch measurements for all parameters
- **Dealing with high beam powers**
 - Non-invasive measurement techniques
 - Robust and reliable machine protection systems
- **Dealing with the ultra-fast**
 - Measurements on the femto-second timescale
- **Dealing with the ultra-low**
 - Measurement of very small beam currents



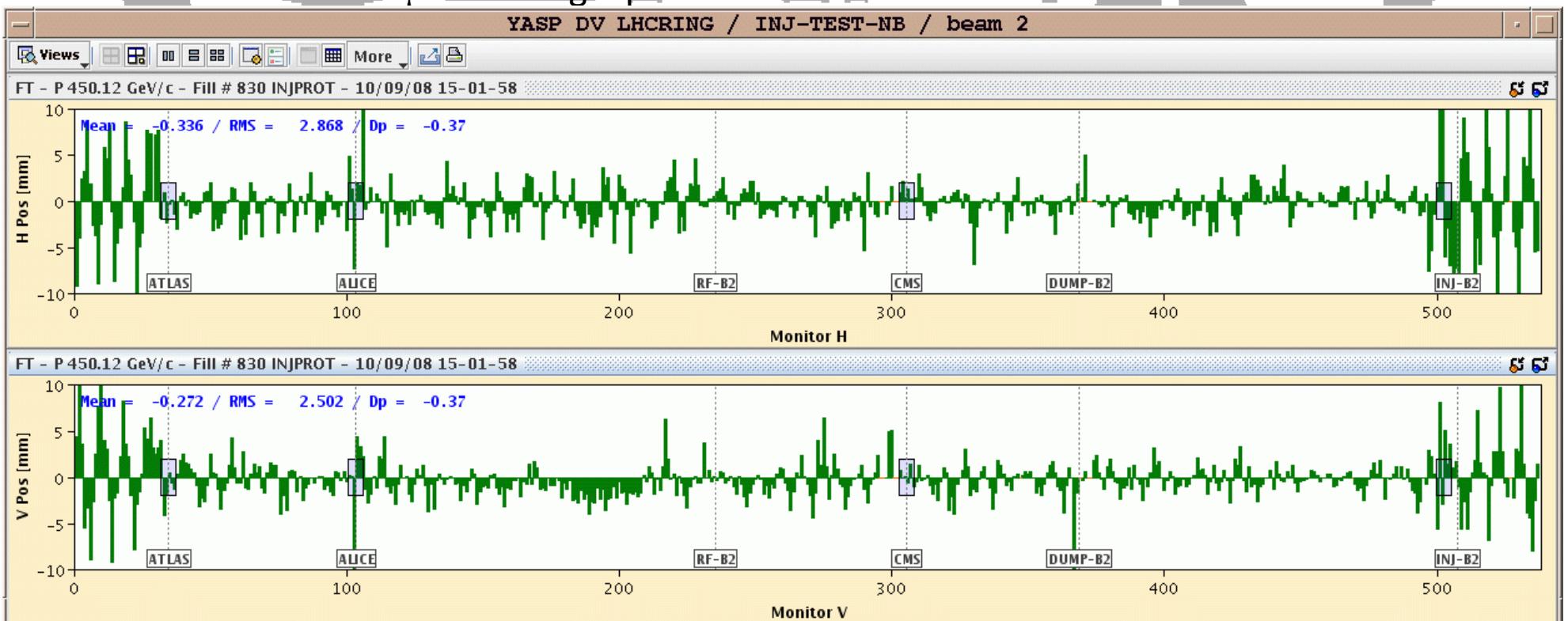
Challenges for Beam Instrumentation

The Quest for Unprecedented Precision

Beam Position Monitoring – The Challenges

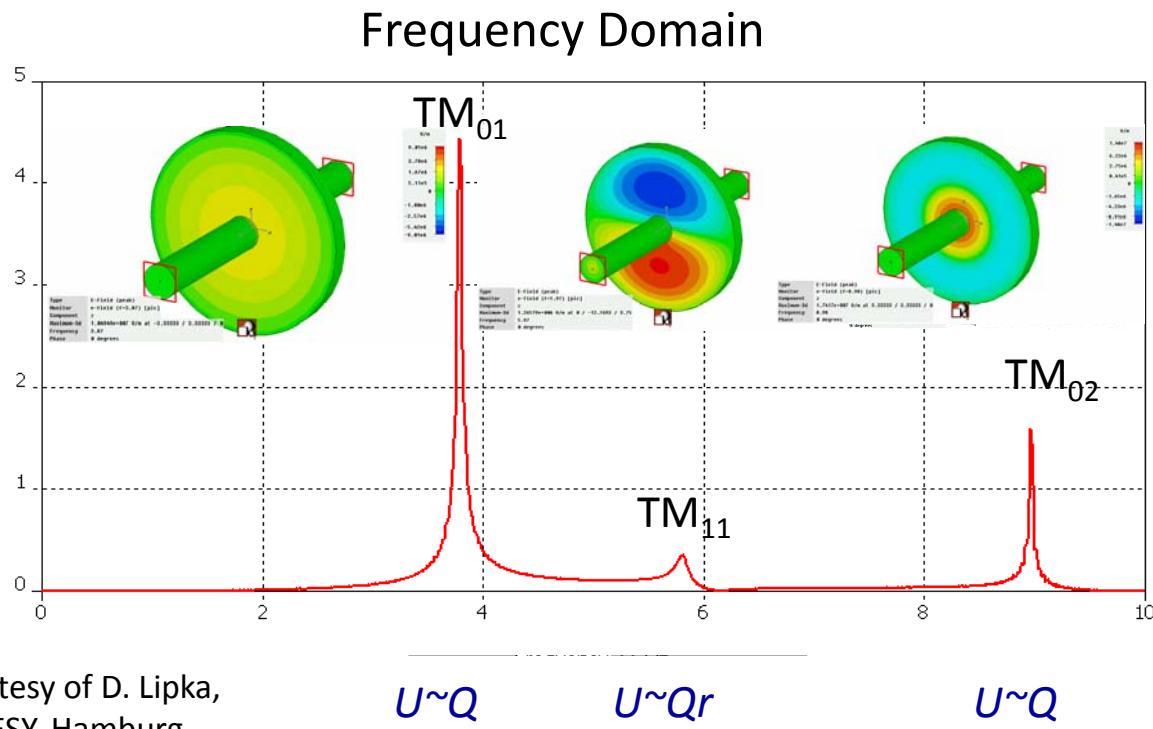
- **Typically one of the largest BI systems**

- LHC has 1100 BPMs – CLIC drive beam requires 40000! This implies:
 - Precision engineering at low cost
 - Simple, robust, yet very highly performing electronics
 - Digitise as soon as possible (now doable with advances in ADCs & digital treatment systems)
 - Radiation Tolerant (improves S/N, minimises expensive cabling BUT needs significant testing time)
- XFEL's and Linear Colliders increasingly asking for very high resolution
 - Well below 1 μ m for single pass



Improving the Precision for Next Generation Accelerators

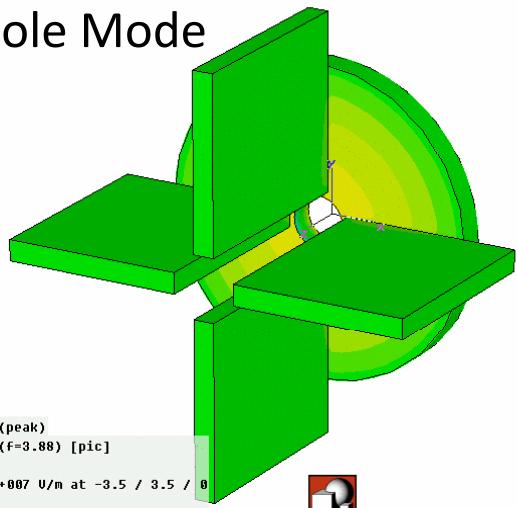
- Standard BPMs give intensity signals - need to subtract them to obtain a difference which is proportional to position
 - Difficult to do electronically without some of the intensity information leaking through
 - When looking for small differences this leakage can dominate the measurement
- Solution – cavity BPMs allowing sub micron resolution
 - Design the detector in such a way as to only collect only the difference signal
 - Dipole Mode TM_{11} proportional to position & shifted in frequency with respect to monopole mode



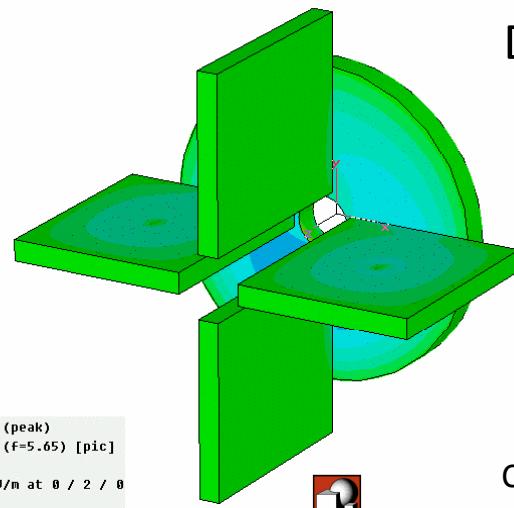
Today's State of the Art BPMs

- Obtain signal using waveguides that only couple to dipole mode
 - Further suppression of monopole mode

Monopole Mode



Dipole Mode

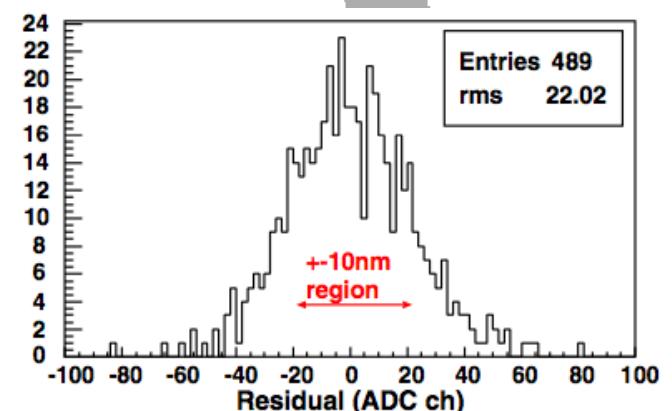
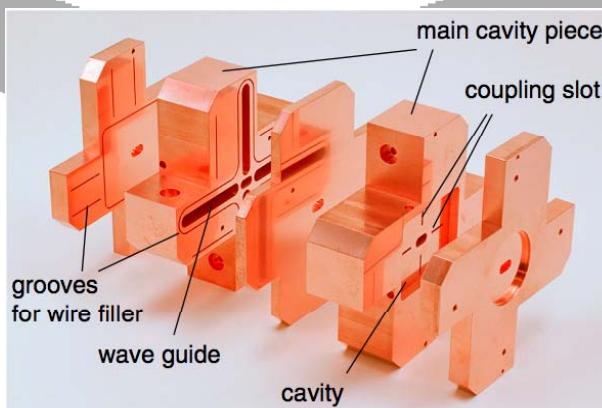
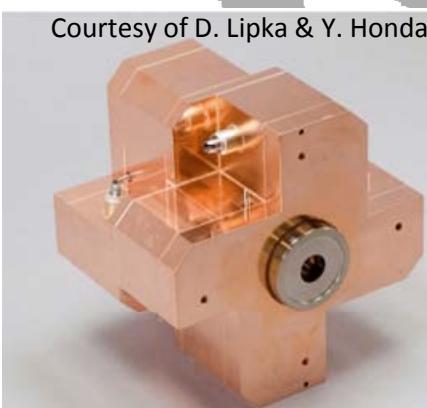


Courtesy of D. Lipka,
DESY, Hamburg

- Prototype BPM for ILC Final Focus

- Required resolution of 2nm (yes nano!) in a 6x12mm diameter beam pipe
- Achieved World Record (so far!) resolution of 8.7nm at ATF2 (KEK, Japan)

Courtesy of D. Lipka & Y. Honda





Challenges for Beam Instrumentation



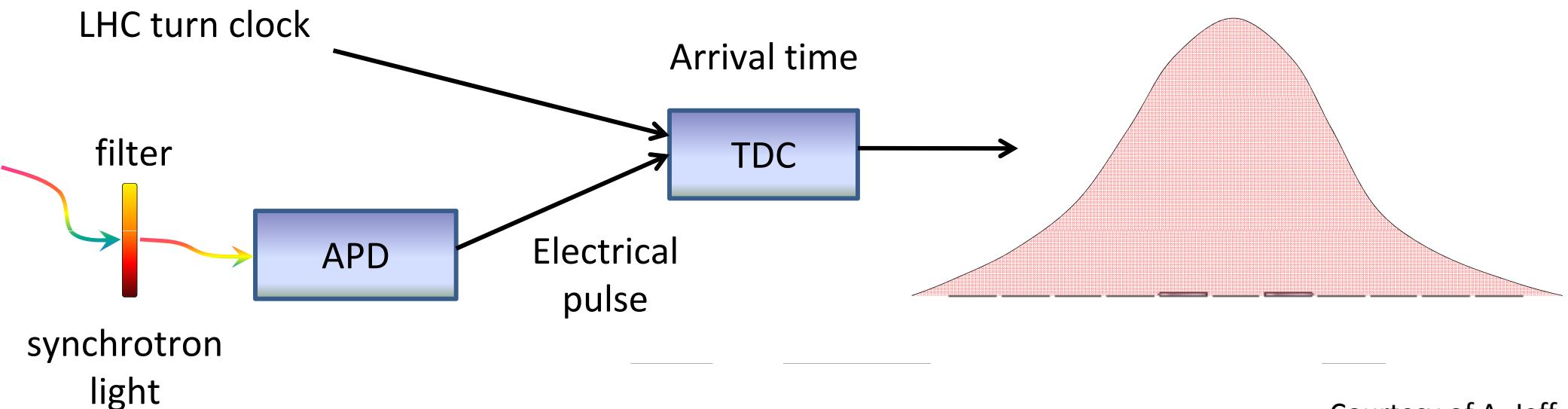
Maximising the Available Data

Maximising the Available Data - Example

• LHC Longitudinal Density Monitor

- Aims:
 - Profile of the whole LHC ring with 50ps resolution
 - High dynamic range for ghost charge measurement
- Method:
 - Single photon counting with Synchrotron light
 - Avalanche photodiode detector
 - 50ps resolution TDC

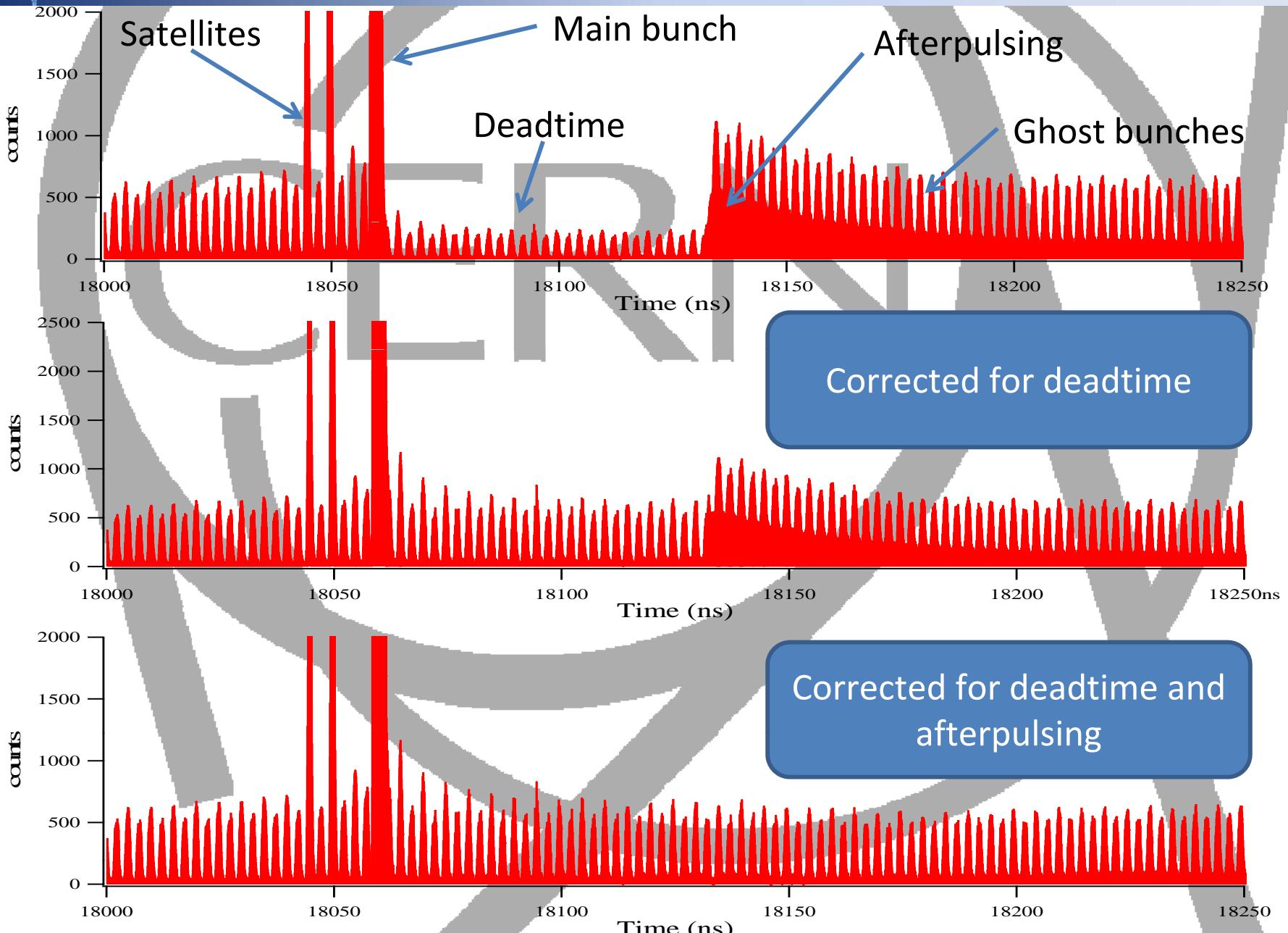
Longitudinal Bunch Shape



Courtesy of A. Jeff



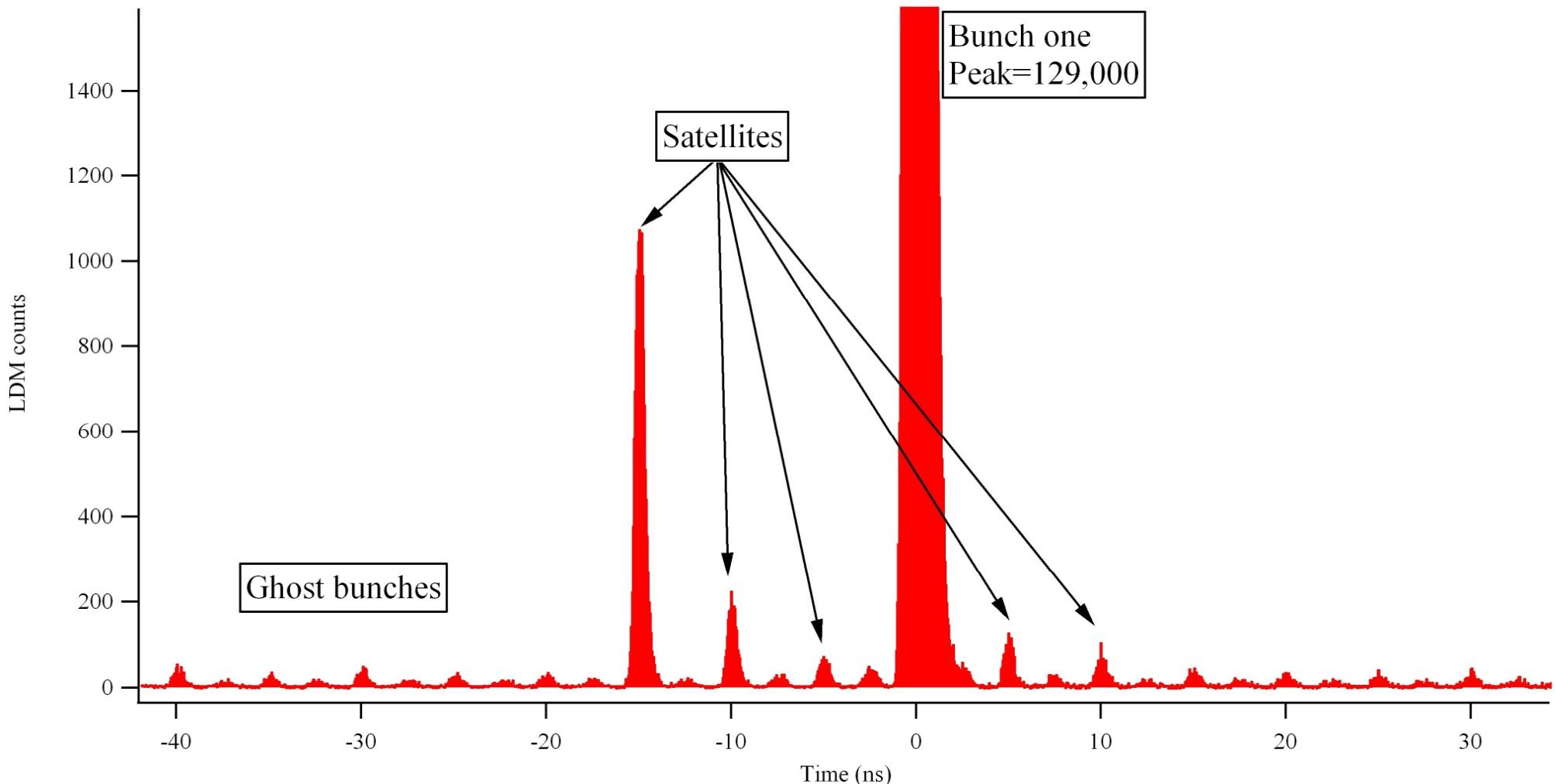
LDM On-line Correction



LDM Results

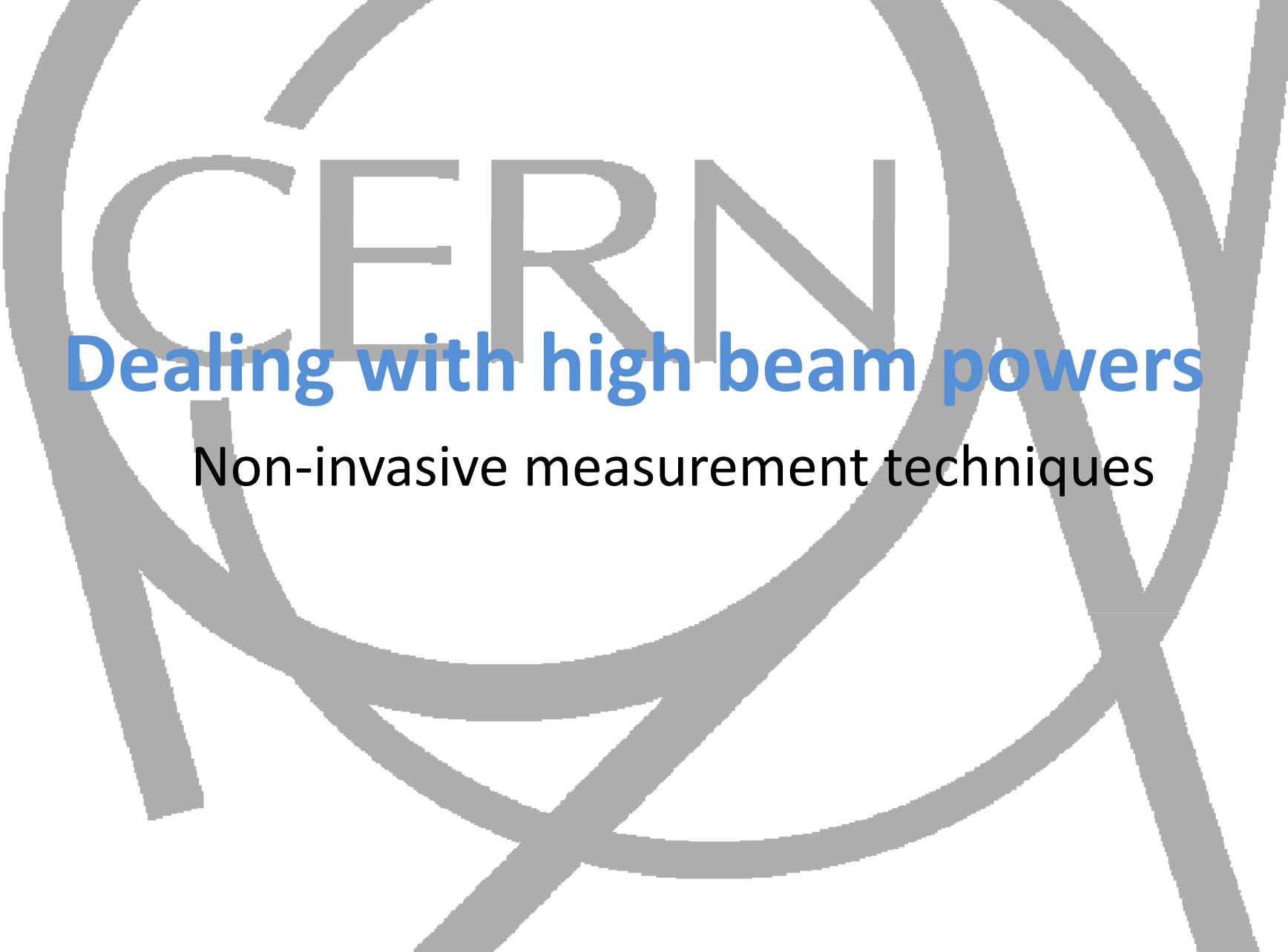
- **Results**

- Able to profile the whole ring within a matter of minutes
- Critical input for accurate luminosity calibration of the experiments





Challenges for Beam Instrumentation



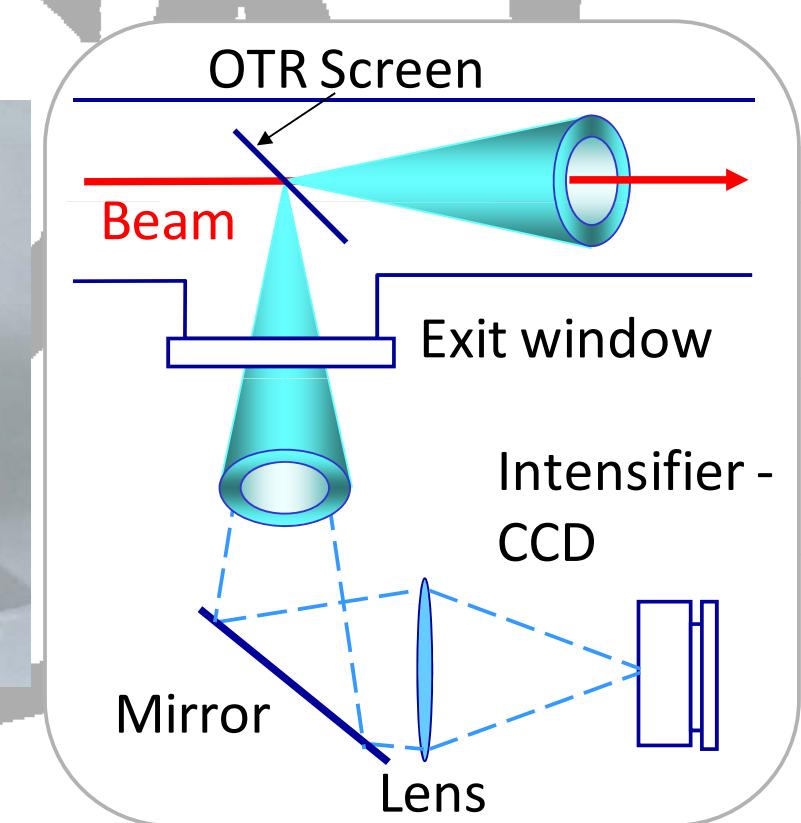
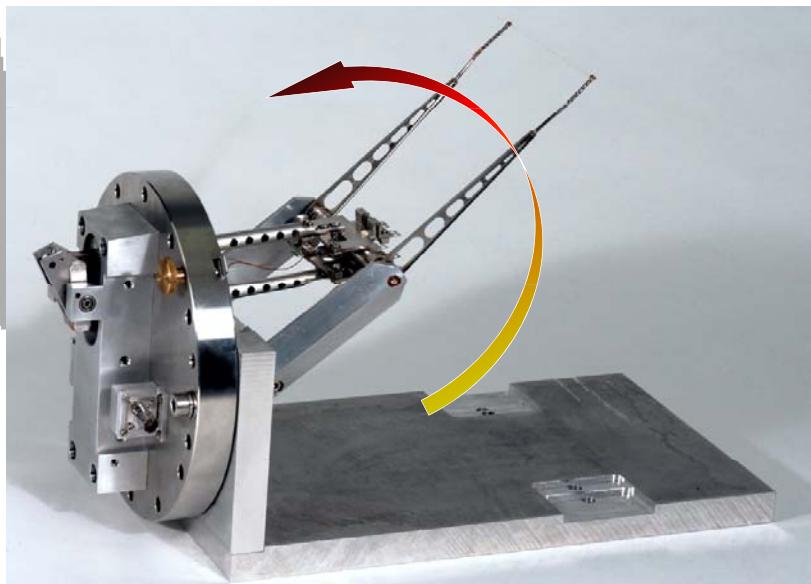
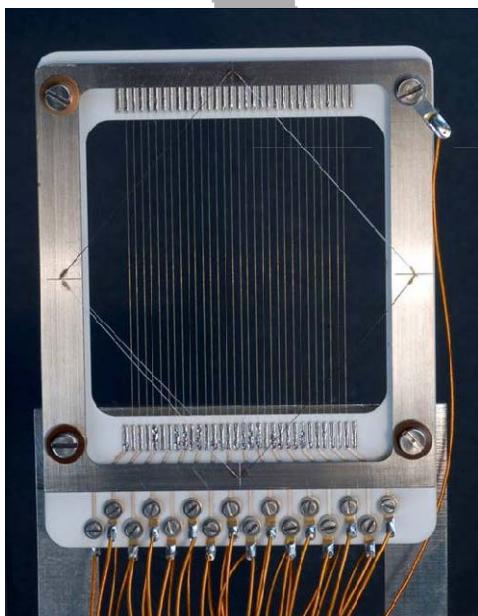
Dealing with high beam powers

Non-invasive measurement techniques

Dealing with High Beam Power - The Issues

- **Traditional invasive diagnostics no longer suitable**

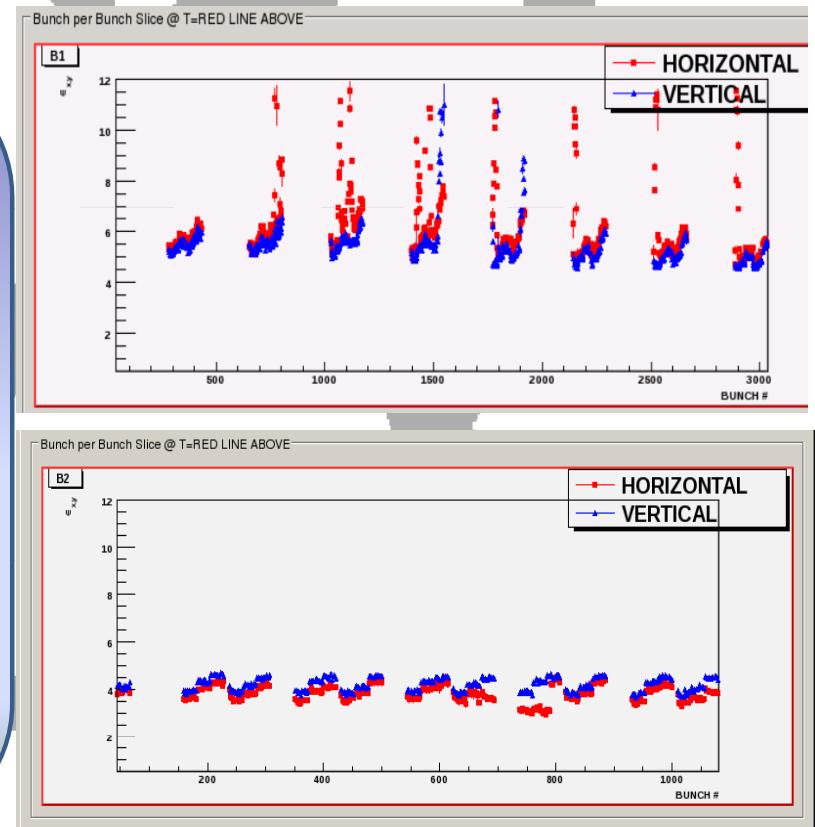
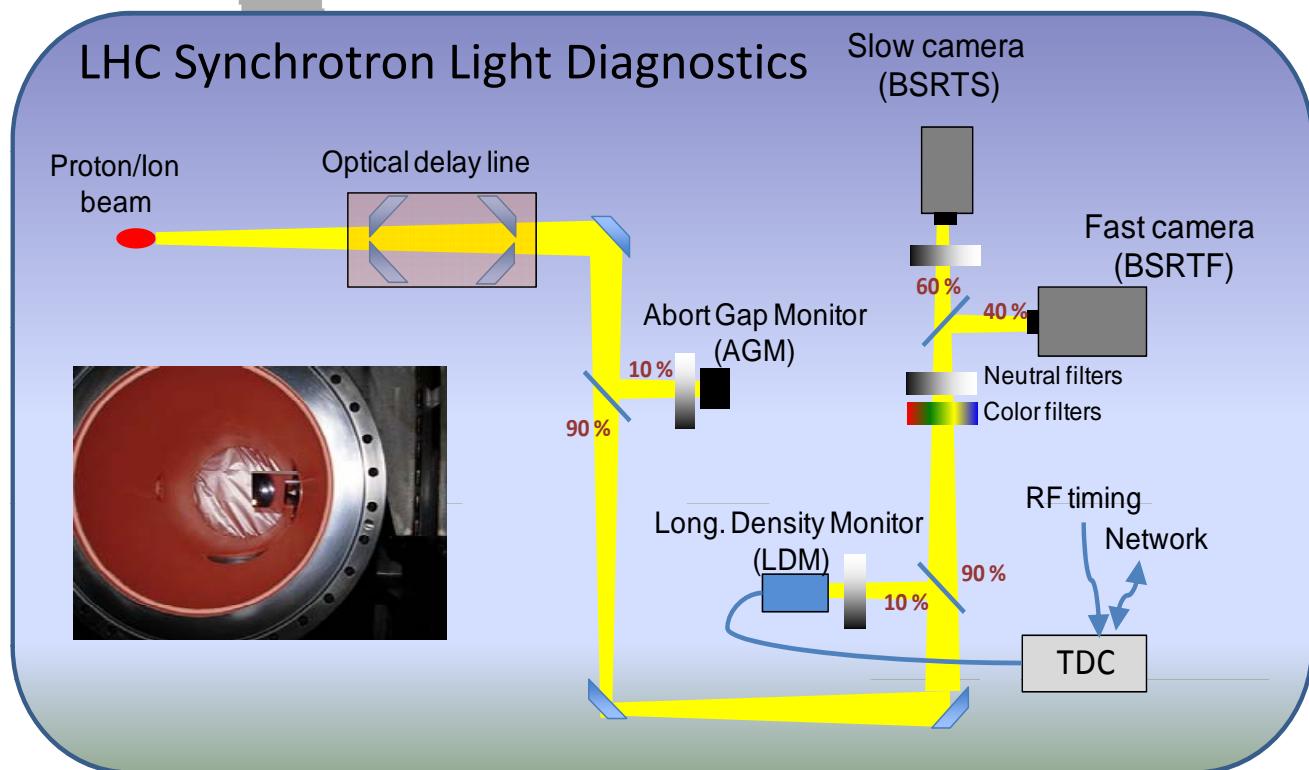
- Materials do not withstand energy deposition
 - Burning of holes or breaking of wires
- Use of superconducting RF structures
 - Risk of contamination on breakage or sputtering of the intercepted material



Measuring the Size of High Power Beams

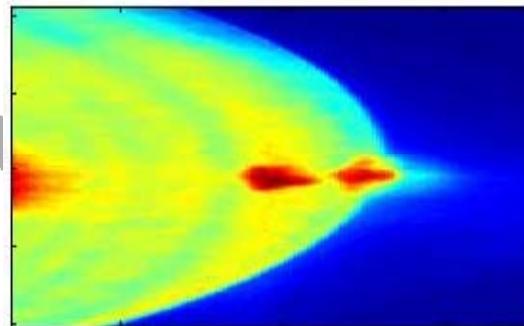
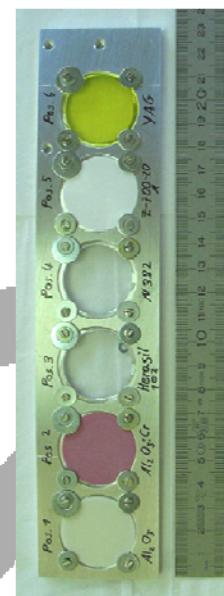
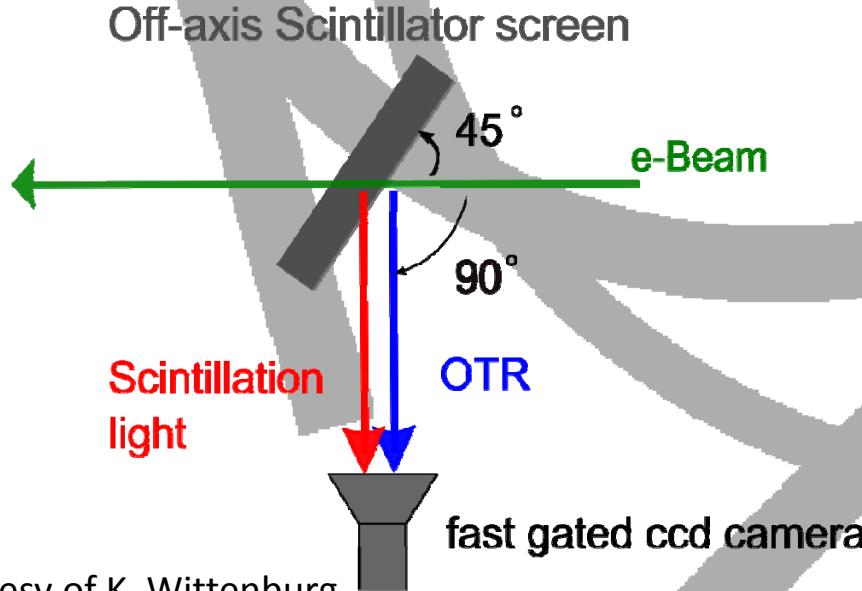
- **Synchrotron Light Diagnostics**

- Only for electron & very high energy proton/ion machines (LHC)
 - Difficult to separate the light from the beam for linear accelerators
- Difficult to get absolute calibration
 - Image correction factors typically bigger than the beam size!
- Additional challenges lie in fast cameras & signal treatment chains for bunch by bunch measurement

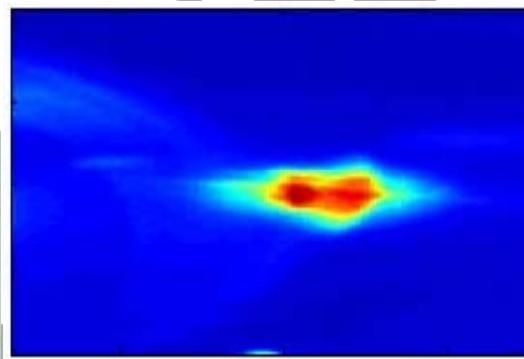


Measuring the Size of Intense Bunches

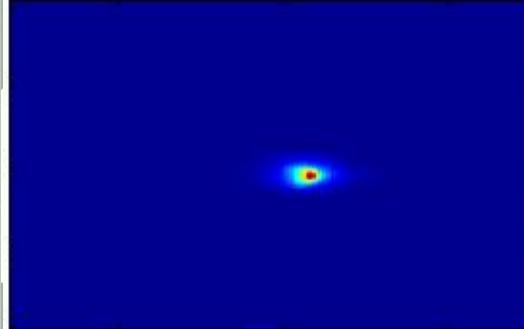
- Standard OTR not an option for short intense bunches (main issue for LCLS)
 - Signal swamped by Coherent OTR from micro-bunching within the main bunch
- One proposal is to go to luminescent Screens
 - There will still be COTR at polished surfaces
 - Resolution might be a problem
- Investigation of temporal suppression of COTR
 - Scintillation screen + fast gated camera
 - Proof-of-principle at FLASH, DESY
- Resolution of scintillation screens needs study
 - Synergy with ion beam diagnostics
 - Similar studies ongoing for FAIR



Al coated Si OTR screen,
COTR light,
Coherent SR



LuAG screen,
COTR &
scintillation light



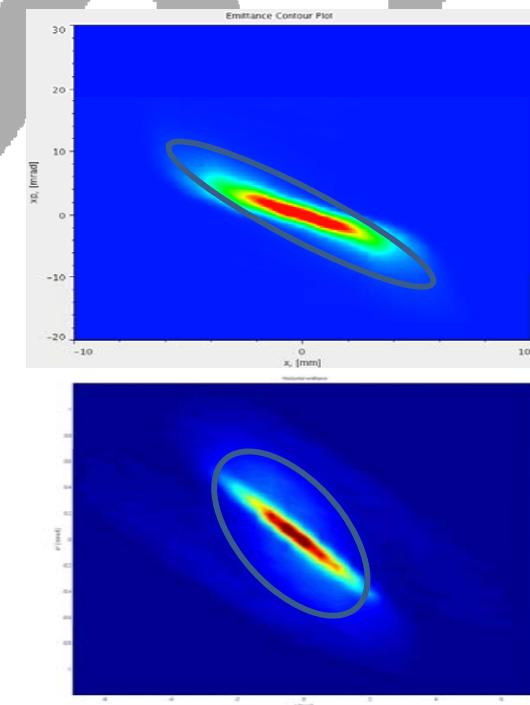
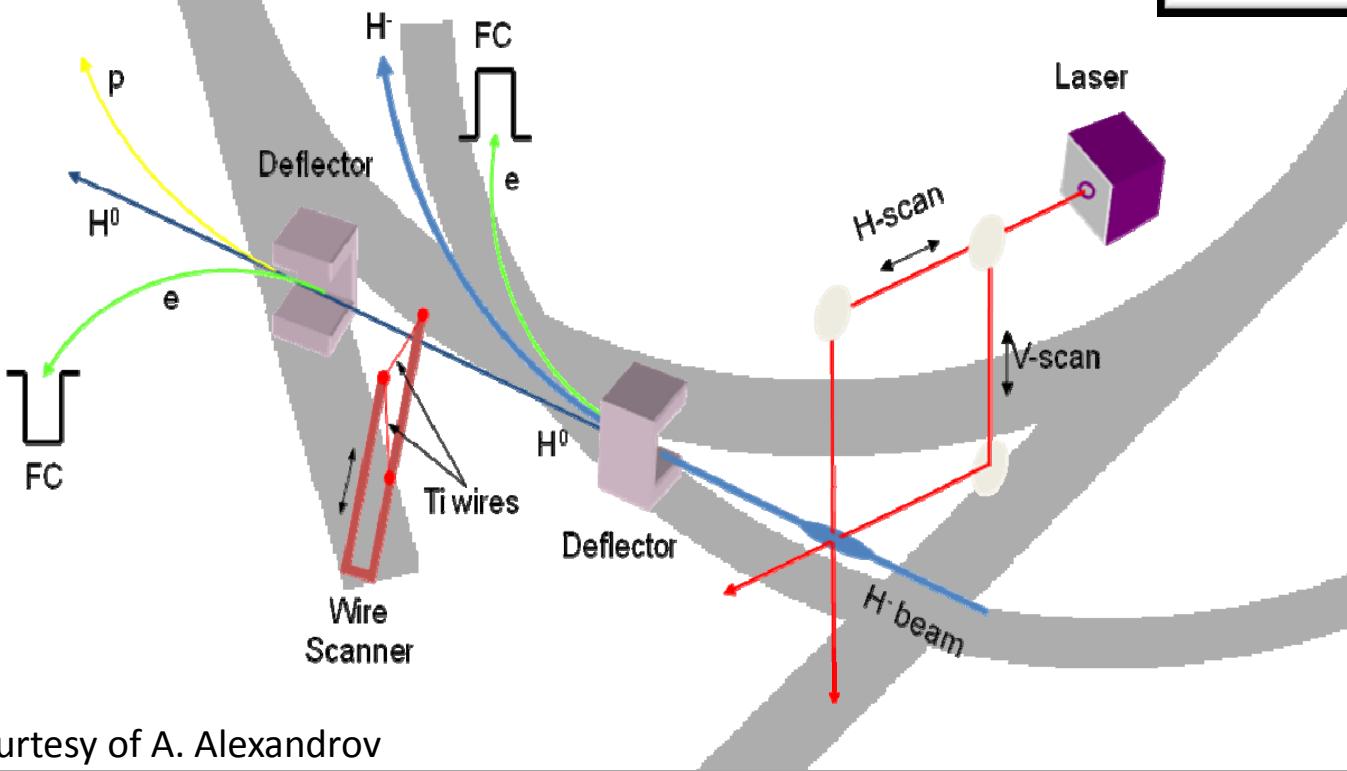
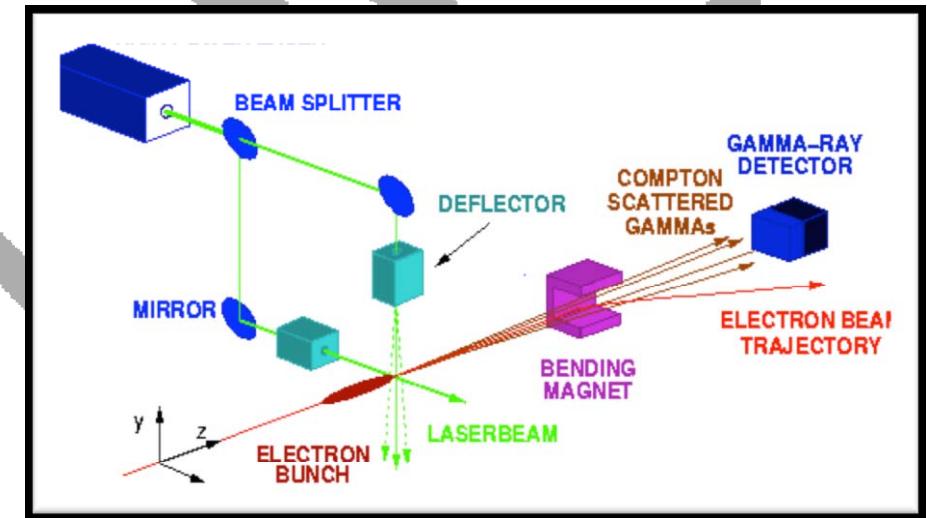
LuAG screen
+100ns delay
Only scintillation light

Courtesy of M. Yan

Non-Invasive Beam Size Measurement

- **Laser wire scanner**

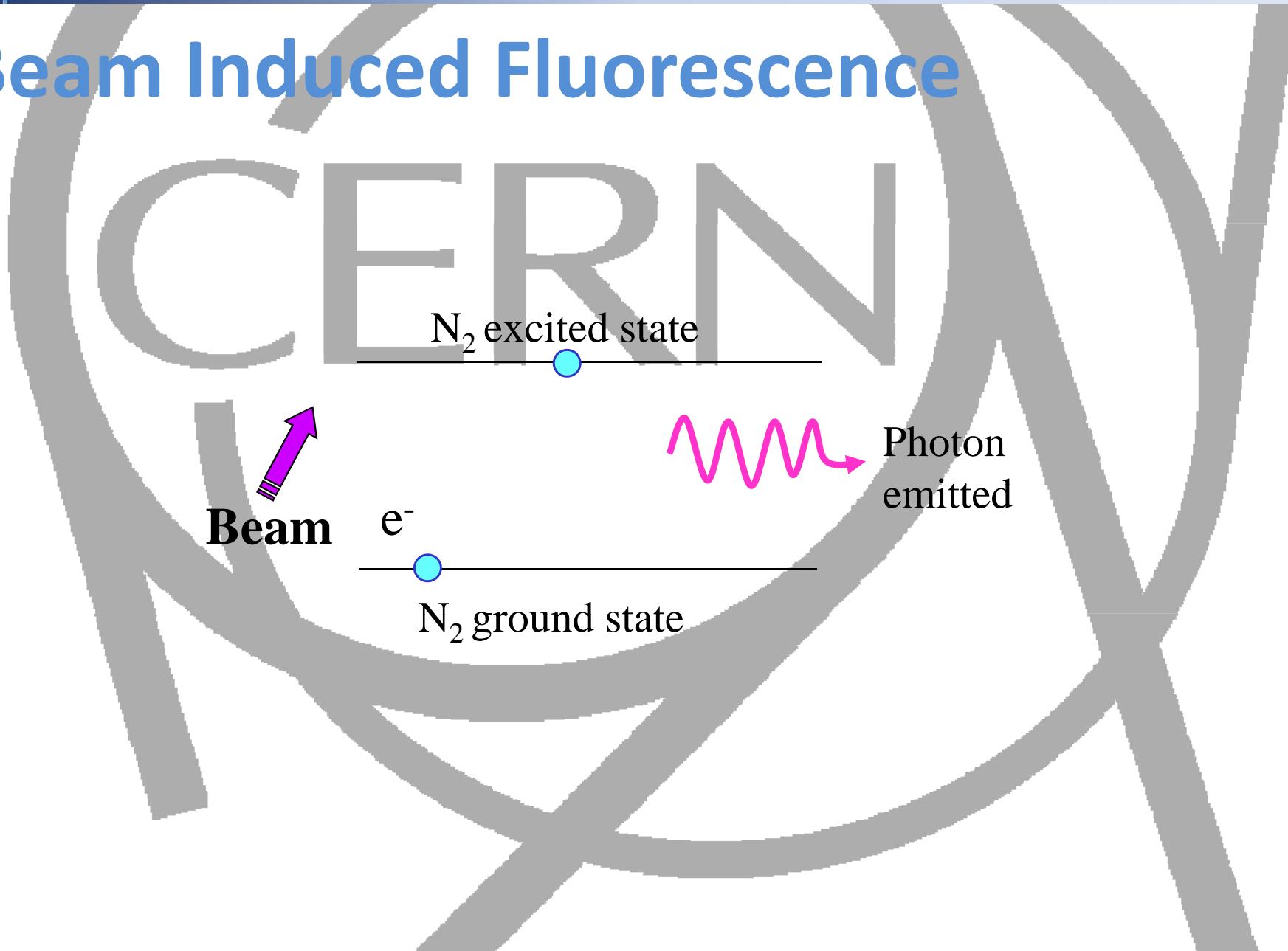
- Good candidate for H^- & electrons
 - Can measure down to micron level
- Needs conversion to turn-key instrument
 - Reliable laser system
 - Laser distribution to multiple measurement stations



Courtesy of A. Alexandrov

Non-Invasive Beam Size Measurement

- Beam Induced Fluorescence

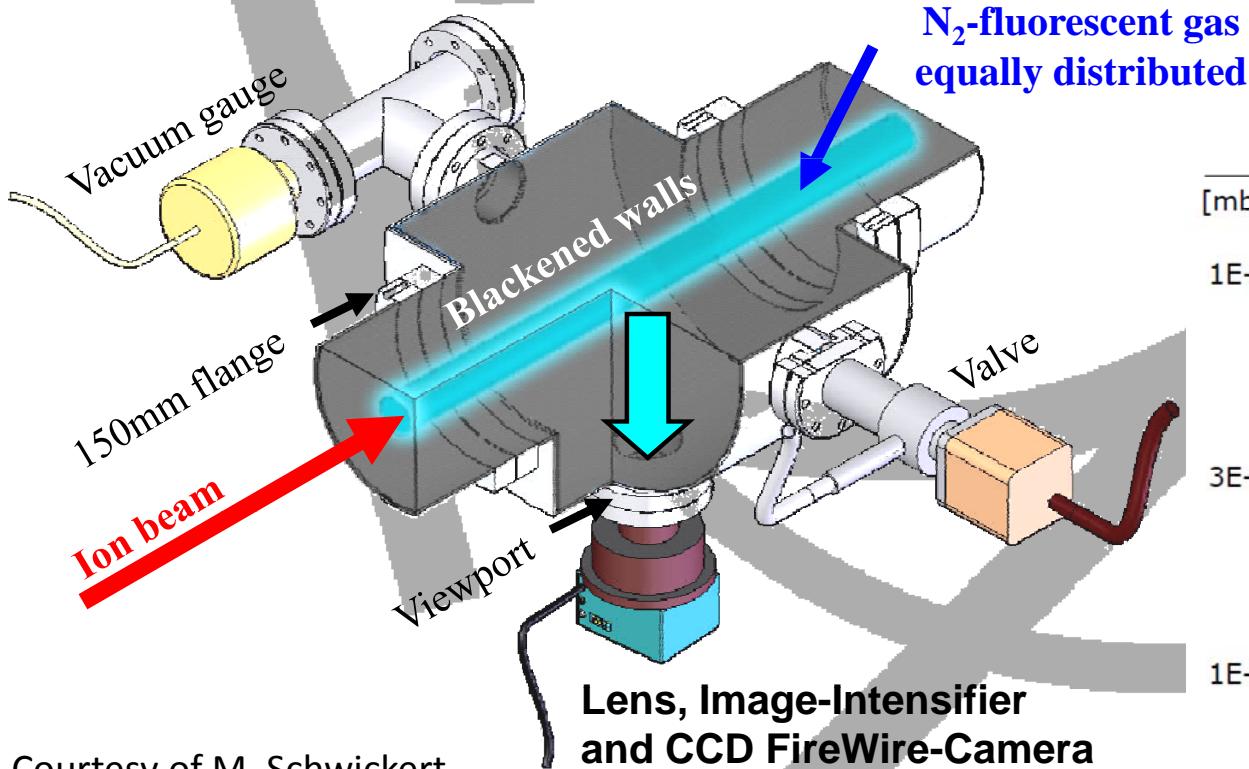


Non-Invasive Beam Size Measurement

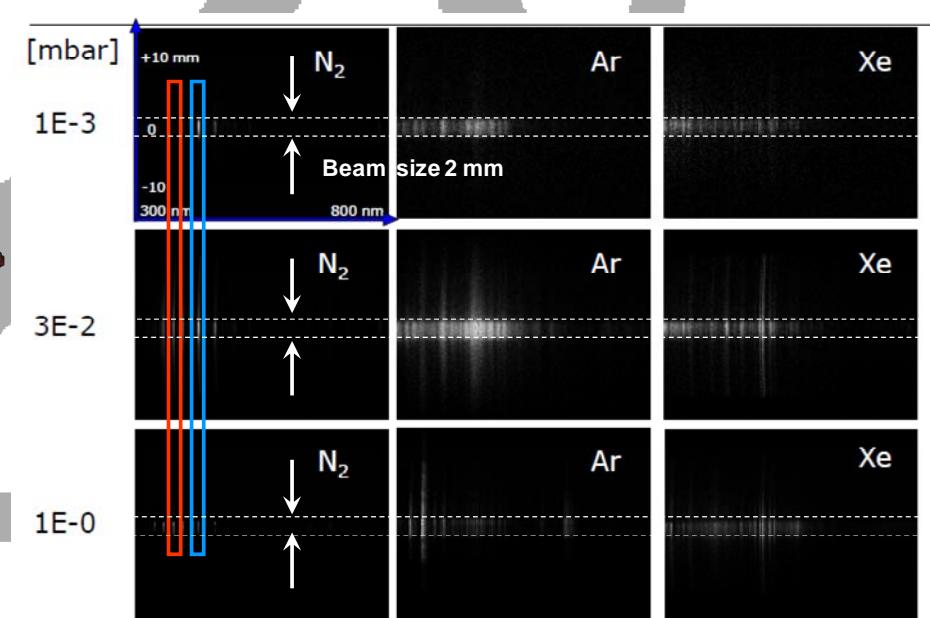
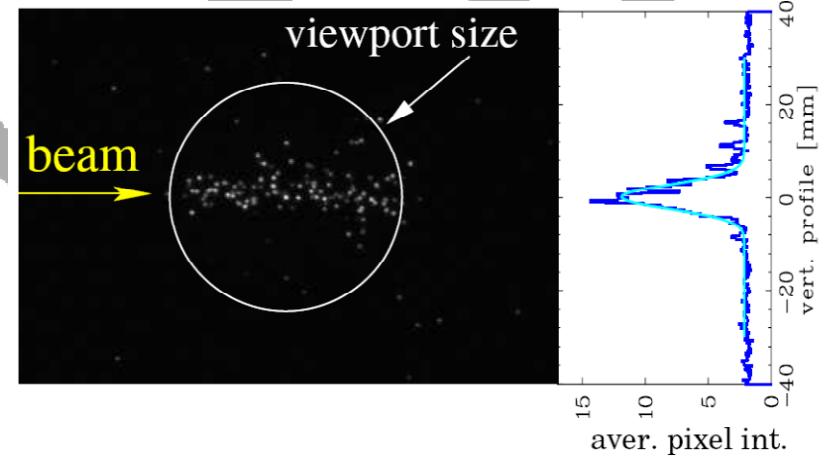
- Beam Induced Fluorescence

- Issues

- Sensitivity to radiation
- Low signal yield \Rightarrow vacuum bump



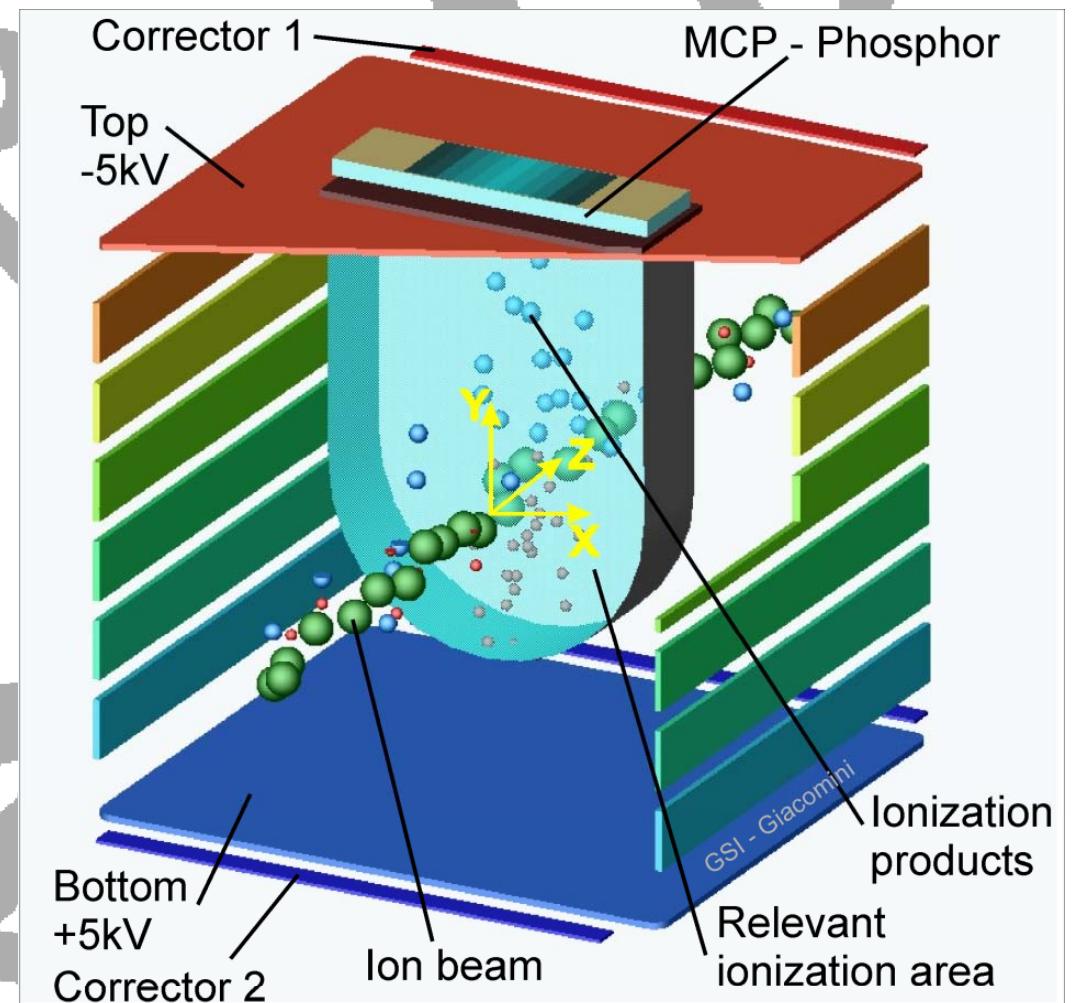
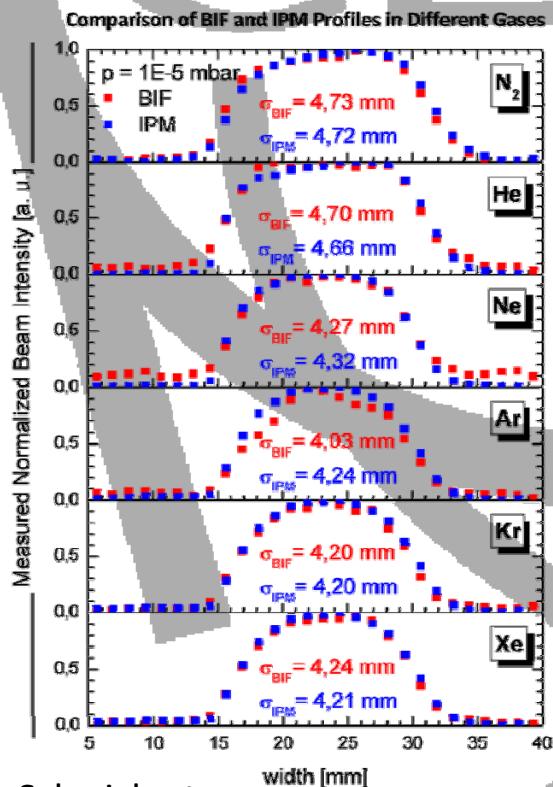
Courtesy of M. Schwickert



Non-Invasive Beam Size Measurement

- **Residual Gas Ionisation**

- Some 10 times more sensitive than BIF
- More complicated to build
 - High voltage network
 - Guiding magnetic field
- Image broadening due to space charge
- Ageing of detectors an issue



Courtesy of M. Schwickert



Challenges for Beam Instrumentation

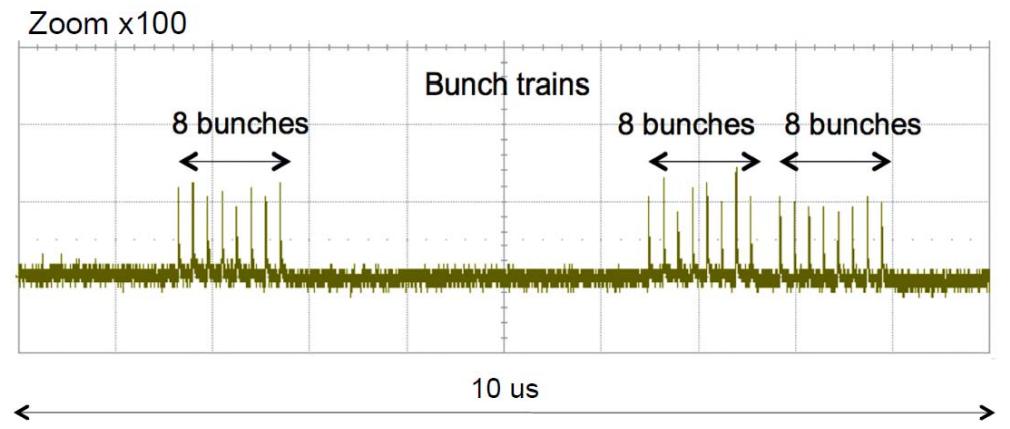
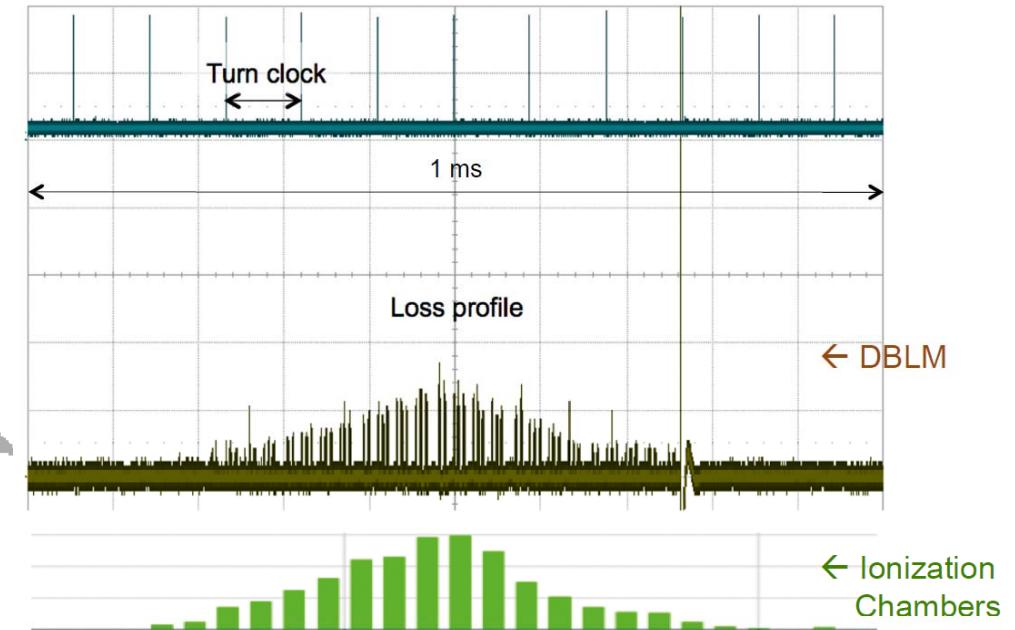
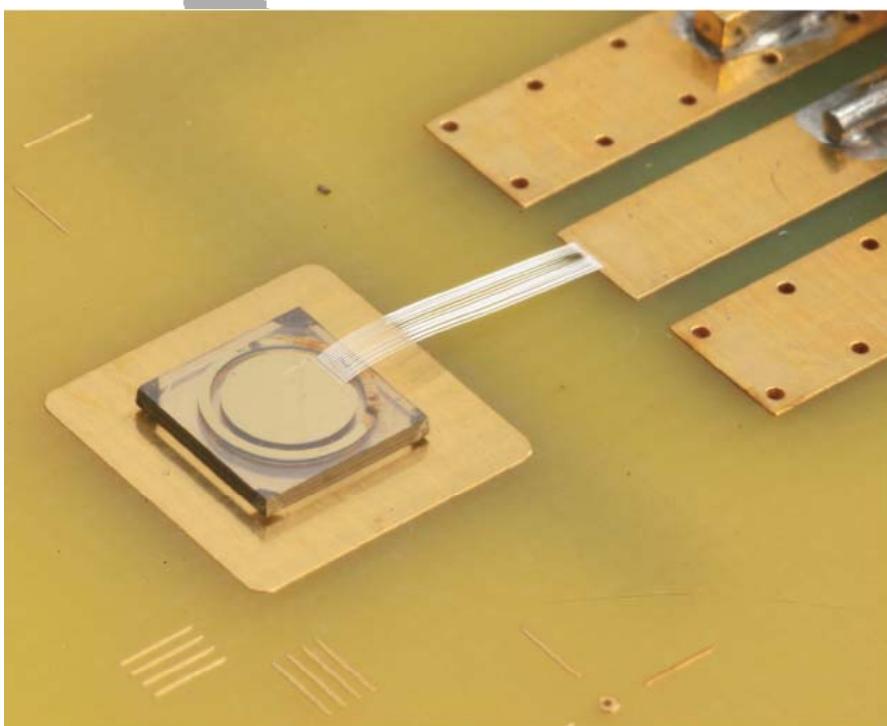
Dealing with high beam powers

Robust and Reliable Machine Protection Systems

Beam Loss Monitors – New Materials

- **Diamond Detectors**

- Fast & sensitive
- Used in LHC to distinguish bunch by bunch losses
- Investigations now ongoing to see if they can work in cryogenic conditions



Courtesy of E. Griesmayer



Challenges for Beam Instrumentation

Dealing with the ultra-fast

Measurements on the femto-second timescale

Ultra-Short Bunch Length Diagnostics

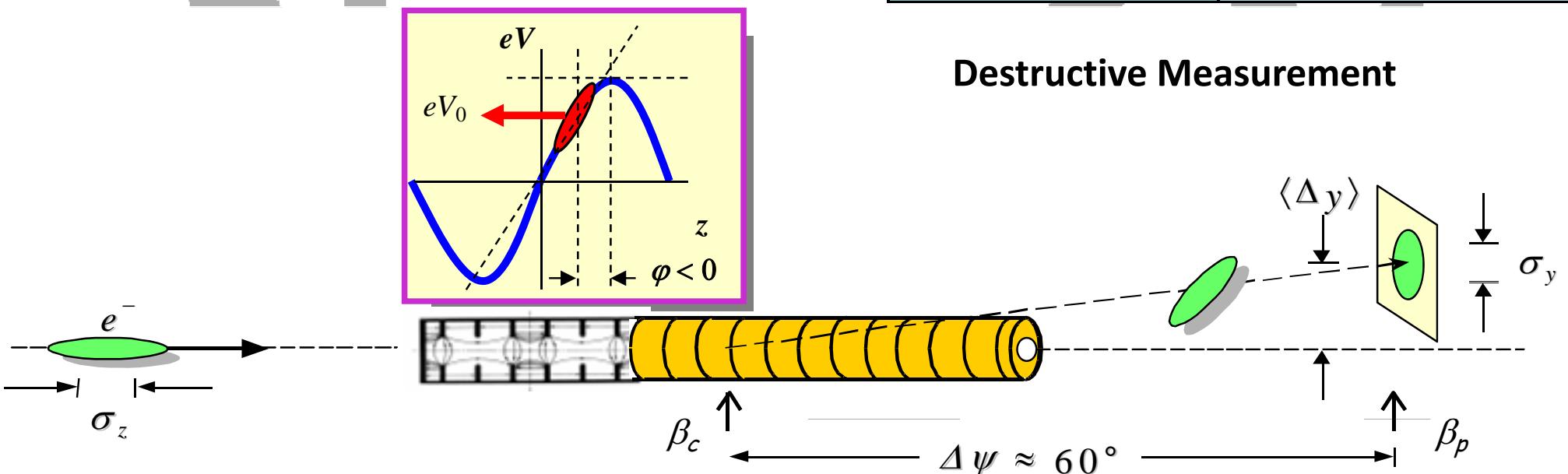
- **Next Generation FELs & Linear Colliders**

- Use ultra short bunches to increase brightness or improve luminosity

- **How do we currently measure such short bunches?**

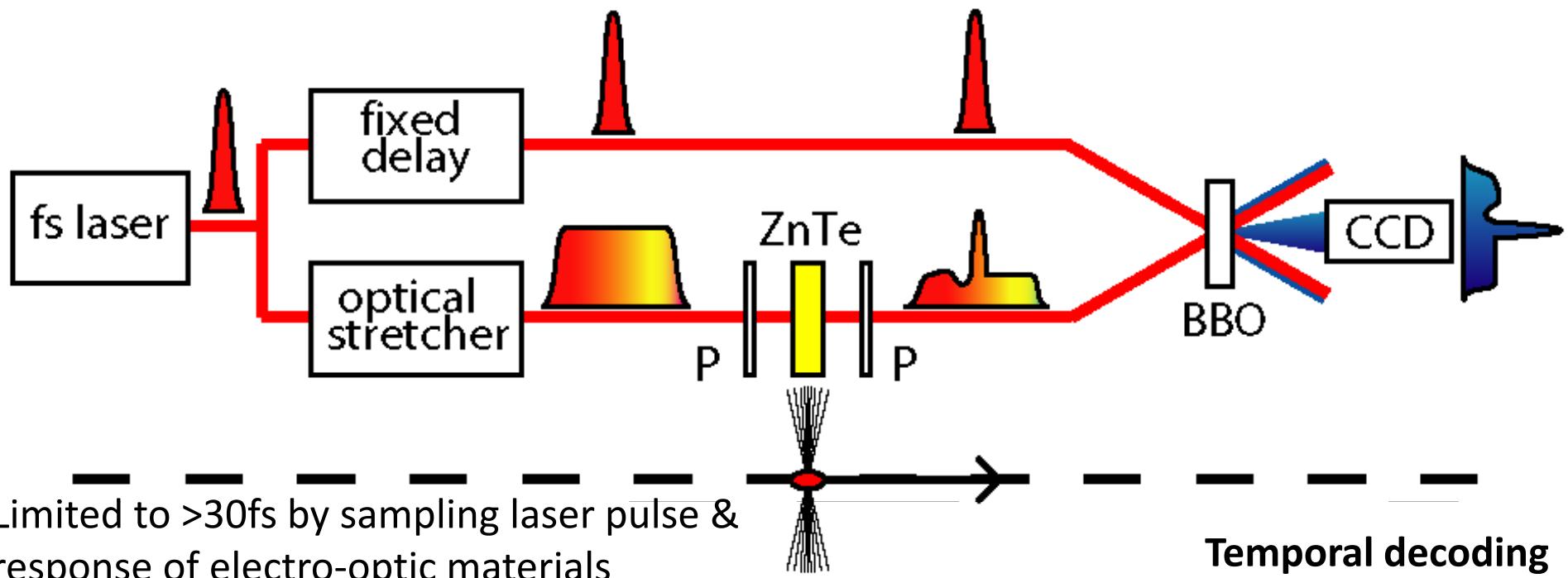
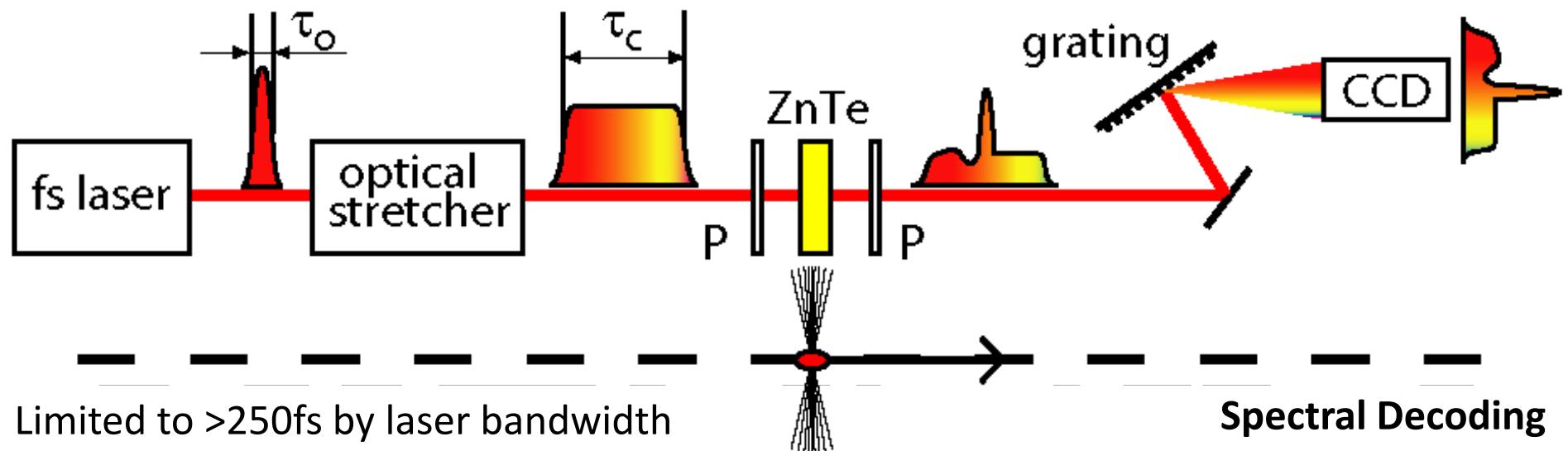
- Transverse deflecting cavity

$p^+ @ LHC$	250ps
$H^- @ SNS$	100ps
$e^- @ ILC$	500fs
$e^- @ CLIC$	130fs
$e^- @ XFEL$	80fs
$e^- @ LCLS$	75fs



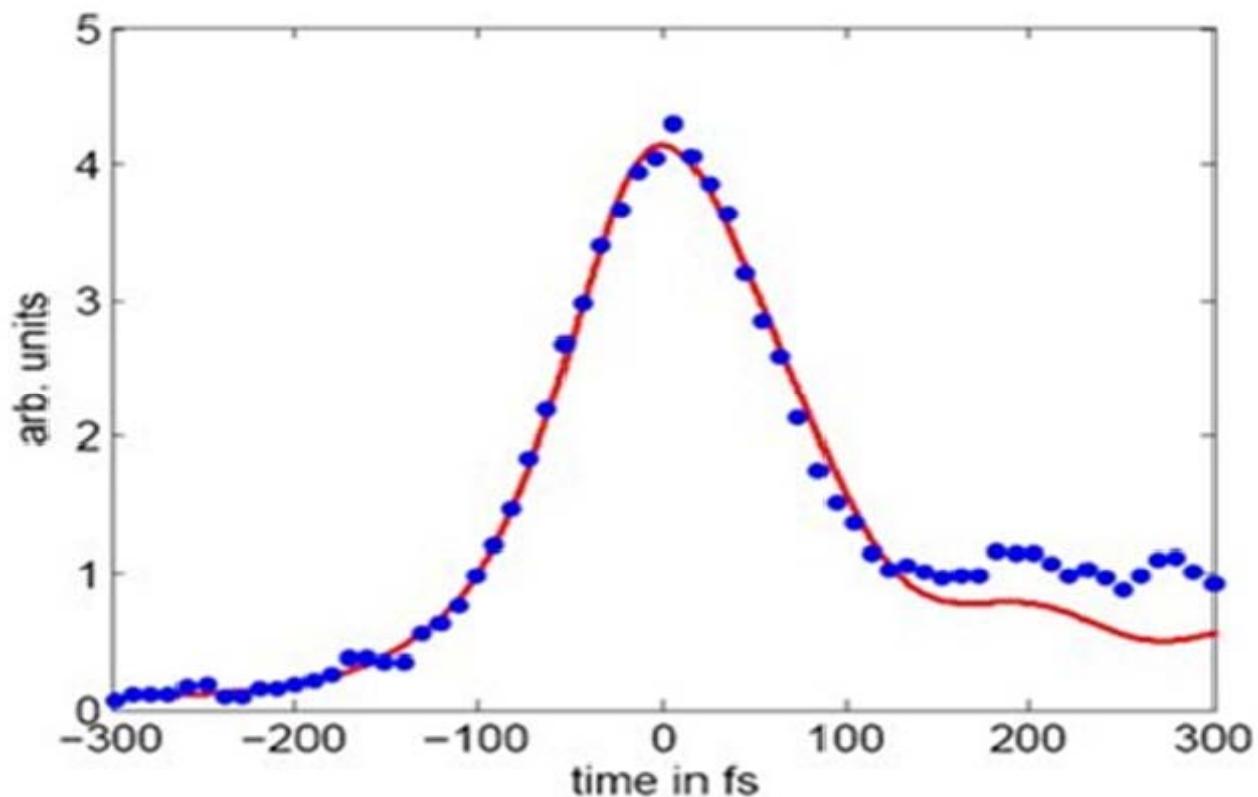
Destructive Measurement

Non Destructive – Electro-Optic Sampling



Non Destructive – Electro-Optic Sampling

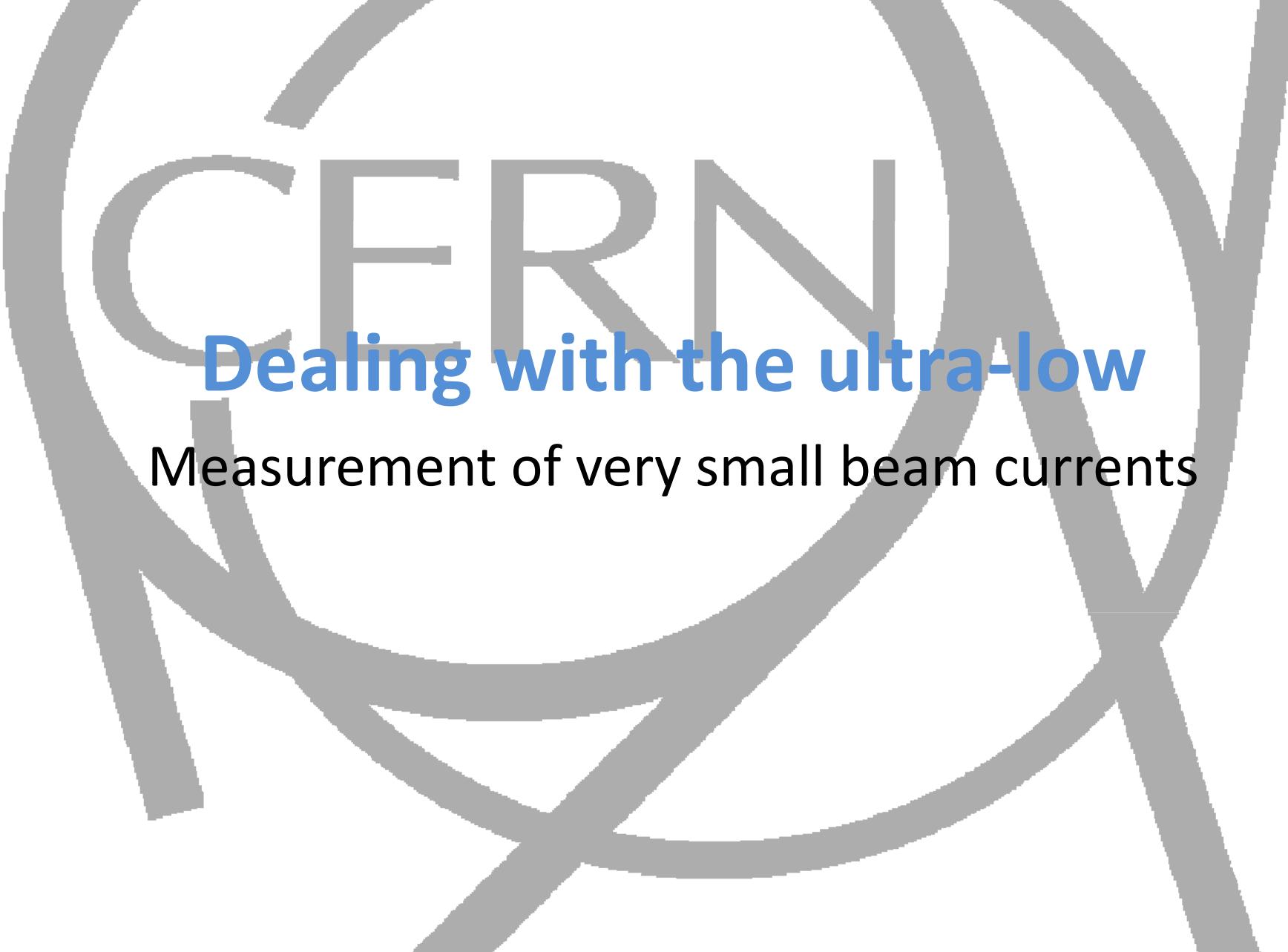
- **Shortest measured electron bunch profile**
 - 79.3 ± 7.5 fs at DESY FLASH
 - Using 65um thick GaP crystal



Courtesy of A. Gillespie



Challenges for Beam Instrumentation

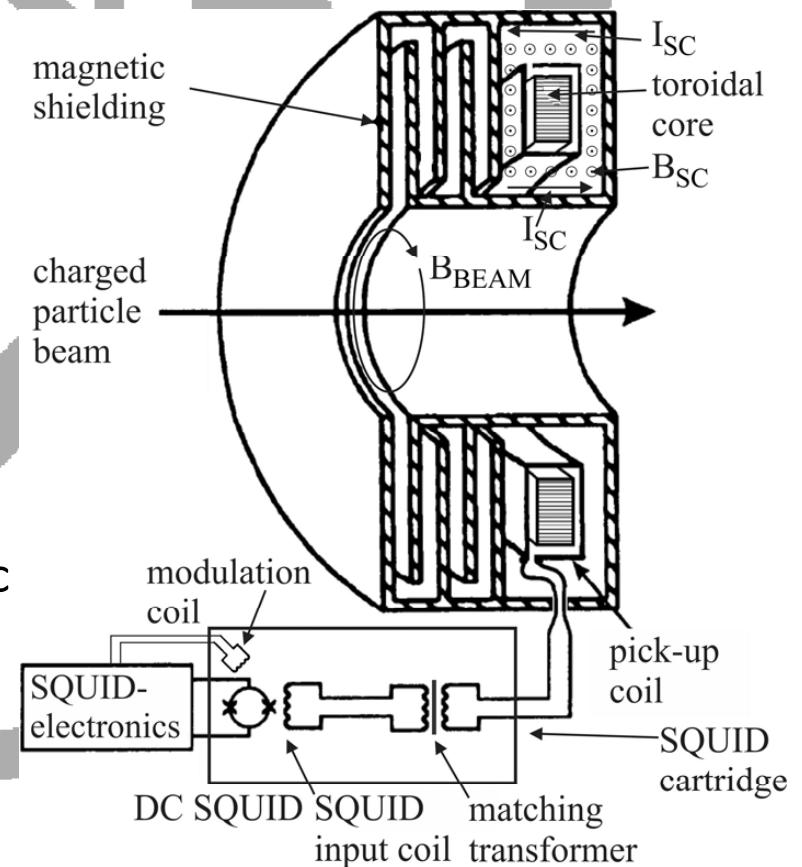


Dealing with the ultra-low

Measurement of very small beam currents

Measuring very low Intensity Beams

- **Measuring rare ions and antiprotons**
 - Currents well below $1\mu\text{A}$ resolution of traditional Direct Current Beam Transformers
- **Superconducting QUantum Interference Devices**
 - Can overcome the limits of conventional systems
 - Both low and high temperature versions have been developed
- **Challenges**
 - Shielding the detector from stray fields
 - Earth's magnetic field $\sim 50\mu\text{T}$
 - Field produced by 100 nA beam at $10 \text{ cm} \sim 0.2 \text{ pT} !$
 - Making the system compact
- **Cryogenic Current Comparator (CCC)**
 - Charged particle beam induces screening currents
 - Toroidal pick-up coil of niobium with ferromagnetic core is used to measure magnetic field
 - Signal from coil is fed through a superconducting transformer for impedance matching to the input coil of the readout DC SQUID.





Conclusion

- Particle Beam Diagnostic systems are continually evolving to meet the requirements of
 - ever more powerful and sophisticated accelerators
 - ever more demanding specifications
- Many synergies between the developments required for all types of new accelerator facilities
 - Ideal subject for collaboration on an international level
 - Was already underway between the major accelerator laboratories worldwide
 - Now strengthened and extended to universities and industry via European Networks

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